

April 1988 Revised September 2000

# 74F125 **Quad Buffer (3-STATE)**

### **Features**

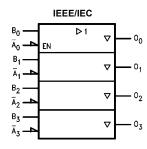
■ High impedance base inputs for reduced loading

## **Ordering Code:**

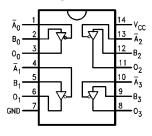
Order Number Package Number			Package Description
			14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
			14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
	74F125PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### **Logic Symbol**



### **Connection Diagram**



## **Unit Loading/Fan Out**

Pin Names	Description	U.L. HIGH/LOW	Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>		
$\overline{A}_n$ , $B_n$	Inputs	1.0/0.033	20 μΑ/–20 μΑ		
On	Outputs	600/106.6 (80)	-12 mA/64 mA (48 mA)		

### **Function Table**

Inp	Output			
Ān	B <sub>n</sub>	o		
L	L	L		
L	Н	Н		
Н	X	Z		

H = HIGH Voltage Level L = LOW Voltage Level

Z = High Impedance X = Immaterial

### **Absolute Maximum Ratings**(Note 1)

-65°C to +150°C Storage Temperature

-55°C to +125°C Ambient Temperature under Bias Junction Temperature under Bias -55°C to +150°C V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0VInput Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

Standard Output –0.5V to  $V_{\mbox{\footnotesize CC}}$ 3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA)

### **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

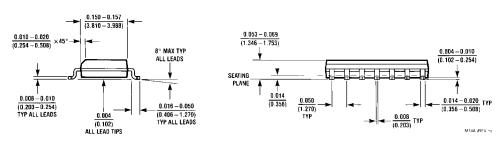
### **DC Electrical Characteristics**

Symbol	Parameter		Min	Тур	Max	Units	V <sub>cc</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage				8.0	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = –18 mA
V <sub>OH</sub>	Output HIGH	2.4					$I_{OH} = -3 \text{ mA}$	
	Voltage	10% V <sub>CC</sub>	2.0			V	Min	$I_{OH} = -12 \text{ mA}$
		5% V <sub>CC</sub>	2.7			v	IVIIII	$I_{OH} = -3 \text{ mA}$
		5% V <sub>CC</sub>	2.0					$I_{OH} = -15 \text{ mA}$
V <sub>OL</sub>	Output LOW	10% V <sub>CC</sub>			0.55	V	Min	I <sub>OL</sub> = 64 mA
	Voltage							
I <sub>IH</sub>	Input HIGH Current				20	μΑ	Max	$V_{IN} = 2.7V$
I <sub>BVI</sub>	Input HIGH Current				100	μА	0.0V	V <sub>IN</sub> = 7.0V
	Breakdown Test				100	μΛ	0.00	VIN - 7:0 V
I <sub>IL</sub>	Input LOW Current				-20.0	μΑ	Max	$V_{IN} = 0.5V$
I <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V
I <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V
Ios	Output Short-Circuit Current		-100		-225	mA	Max	V <sub>OUT</sub> = 0V
I <sub>CEX</sub>	Output HIGH Leakage Currer	nt			250	μΑ	Max	$V_{OUT} = V_{CC}$
I <sub>ZZ</sub>	Buss Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V
I <sub>CCH</sub>	Power Supply Current			18.5	24.0	mA	Max	V <sub>O</sub> = HIGH
I <sub>CCL</sub>	Power Supply Current			31.7	40.0	mA	Max	$V_O = LOW$
I <sub>CCZ</sub>	Power Supply Current			27.6	35.0	mA	Max	V <sub>O</sub> = HIGH Z

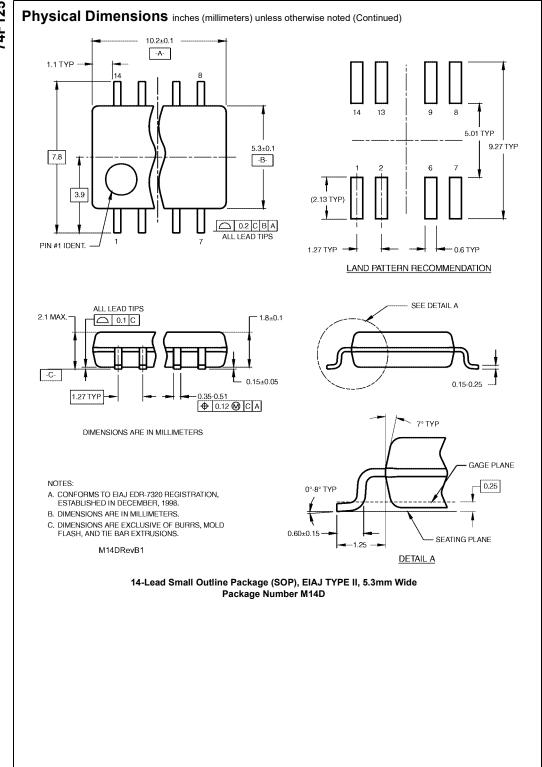
### **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units	
		Min	Тур	Max	Min	Max		
t <sub>PLH</sub>	Propagation Delay	2.0	4.0	6.0	2.0	6.5	no	
t <sub>PHL</sub>		3.0	4.6	7.5	3.0	8.0	ns	
t <sub>PZH</sub>	Output Enable Time	3.5	4.7	7.5	3.0	8.5	ns	
t <sub>PZL</sub>		3.5	5.3	8.0	3.5	9.0	115	
t <sub>PHZ</sub>	Output Disable Time	1.5	3.9	5.5	1.5	6.0	ns	
$t_{PLZ}$		1.5	4.0	6.0	1.5	6.5	115	

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14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow Package Number M14A



### Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.770 (18.80 - 19.56)0.090 (2.286) 14 13 12 14 13 12 11 10 9 8 0.250 ± 0.010 (6.350 ± 0.254) PIN NO. 1 IDENT PIN NO. 1 IDENT 1 2 3 4 5 6 7 1 2 3 $\frac{0.092}{(2.337)}$ DIA 0.030 MAX (0.762) DEPTH OPTION 1 OPTION 02 $\frac{0.135 \pm 0.005}{(3.429 \pm 0.127)}$ 0.300 - 0.320 $\overline{(7.620 - 8.128)}$ 0.065 $\frac{0.145 - 0.200}{(3.683 - 5.080)}$ 0.060 4° TYP Optional (1.524) (1.651) $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 0.020 (0.508) 0.125 - 0.150 $0.075 \pm 0.015$ $\overline{(3.175 - 3.810)}$ 0.280

14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

 $\frac{0.050\pm0.010}{(1.270-0.254)}$  TYP

 $(1.905 \pm 0.381)$ 

0.100±0.010 (2.540±0.254)

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### LIFE SUPPORT POLICY

0.014-0.023 TYP

(0.356 - 0.584)

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- 2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

(7.112) MIN

0.325 <sup>+0.040</sup> -0.015 8.255 + 1.016

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N14A (REV F)